Search Notes

Application/Contr I No.	Applicant(s)/Patent	Applicant(s)/Patent under Reexamination	
10/800,549	RIBARICH ET AL.	RIBARICH ET AL.	
Examiner	Art Unit		
Y. J. Han	2838		

SEARCHED				
Class	Subclass	Date	Examiner	
323	225			
,	242			
	247			
	259			
	282			
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	290			
363	25		-	
Search	updated	7/9/2006	/JH/	

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

(INCLUDING SEA	RCH STRATEG	Y)
	DATE	EXMF